Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/600,555	LI, JIN	
Examiner	Art Unit	
Duy M. Dang	2624	

SEARCHED			
Class	Subclass	Date	Examiner
382	232 233 240 246 247	7/20/2007	DD
375	240		1
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INTERFERENCE SEARCHED			
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	DATE	EXMR
East (uspto, derwent, jpo, epo, pgpub), see printouts	7/20/2007	DD
Inventor search (east), see printout		